

# 1.2V Drive Pch MOSFET

## RU1C002ZP

### ● Structure

Silicon P-channel MOSFET

### ● Features

- 1) Low on-resistance.
- 2) Low voltage drive(1.2V drive).

### ● Application

Switching

### ● Packaging specifications

Type	Package	Taping
	Code	TCL
	Basic ordering unit (pieces)	3000
RU1C002ZP		○

### ● Absolute maximum ratings (Ta = 25°C)

Parameter	Symbol	Limits	Unit	
Drain-source voltage	$V_{DSS}$	-20	V	
Gate-source voltage	$V_{GSS}$	±10	V	
Drain current	Continuous	$I_D$	±200	mA
	Pulsed	$I_{DP}$ *1	±800	mA
Source current (Body Diode)	Continuous	$I_S$	-100	mA
	Pulsed	$I_{SP}$ *1	-800	mA
Power dissipation	$P_D$ *2	150	mW	
Channel temperature	$T_{ch}$	150	°C	
Range of storage temperature	$T_{stg}$	-55 to +150	°C	

\*1  $P_w \leq 10\mu s$ , Duty cycle  $\leq 1\%$

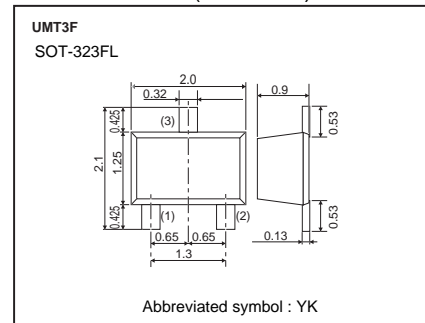
\*2 Each terminal mounted on a reference land.

### ● Thermal resistance

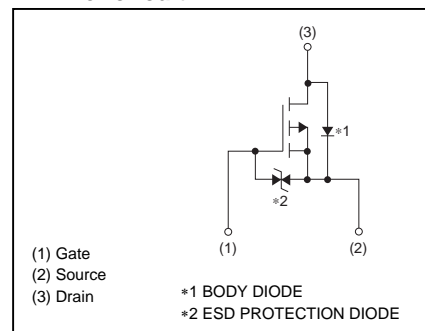
Parameter	Symbol	Limits	Unit
Channel to Ambient	$R_{th}(ch-a)^*$	833	°C / W

\* Each terminal mounted on a reference land.

### ● Dimensions (Unit : mm)



### ● Inner circuit



● **Electrical characteristics** (Ta = 25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	$I_{GSS}$	-	-	±10	μA	$V_{GS}=\pm 10V, V_{DS}=0V$
Drain-source breakdown voltage	$V_{(BR)DSS}$	-20	-	-	V	$I_D=-1mA, V_{GS}=0V$
Zero gate voltage drain current	$I_{DSS}$	-	-	-1	μA	$V_{DS}=-20V, V_{GS}=0V$
Gate threshold voltage	$V_{GS(th)}$	-0.3	-	-1.0	V	$V_{DS}=-10V, I_D=-100\mu A$
Static drain-source on-state resistance	$R_{DS(on)}^*$	-	0.8	1.2	Ω	$I_D=-200mA, V_{GS}=-4.5V$
		-	1.0	1.5		$I_D=-100mA, V_{GS}=-2.5V$
		-	1.3	2.2		$I_D=-100mA, V_{GS}=-1.8V$
		-	1.6	3.5		$I_D=-40mA, V_{GS}=-1.5V$
		-	2.4	9.6		$I_D=-10mA, V_{GS}=-1.2V$
Forward transfer admittance	$ Y_{fs} ^*$	0.2	-	-	S	$V_{DS}=-10V, I_D=-200mA$
Input capacitance	$C_{iss}$	-	115	-	pF	$V_{DS}=-10V$
Output capacitance	$C_{oss}$	-	10	-	pF	$V_{GS}=0V$
Reverse transfer capacitance	$C_{rss}$	-	6	-	pF	$f=1MHz$
Turn-on delay time	$t_{d(on)}^*$	-	6	-	ns	$V_{DD}=-10V, I_D=-100mA$
Rise time	$t_r^*$	-	4	-	ns	$V_{GS}=-4.5V$
Turn-off delay time	$t_{d(off)}^*$	-	17	-	ns	$R_L=100\Omega$
Fall time	$t_f^*$	-	17	-	ns	$R_G=10\Omega$
Total gate charge	$Q_g$	-	1.4	-	nC	$V_{DD}=-10V, I_D=-200mA$
Gate-source charge	$Q_{gs}$	-	0.3	-	nC	$V_{GS}=-4.5V$
Gate-drain charge	$Q_{gd}$	-	0.3	-	nC	

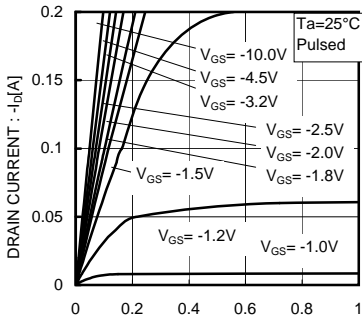
\*Pulsed

● **Body diode characteristics** (Source-Drain)

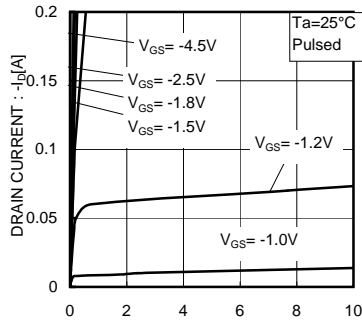
Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward Voltage	$V_{SD}^*$	-	-	-1.2	V	$I_S=-200mA, V_{GS}=0V$

\*Pulsed

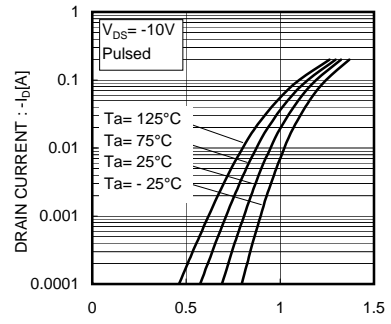
●Electrical characteristic curves (Ta = 25°C)



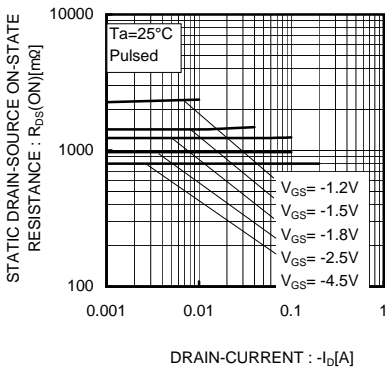
DRAIN-SOURCE VOLTAGE : -V<sub>DS</sub>[V]  
Fig.1 Typical output characteristics( I )



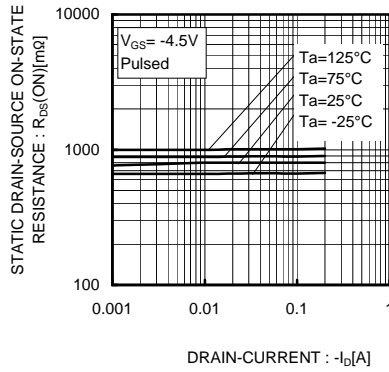
DRAIN-SOURCE VOLTAGE : -V<sub>DS</sub>[V]  
Fig.2 Typical output characteristics( II )



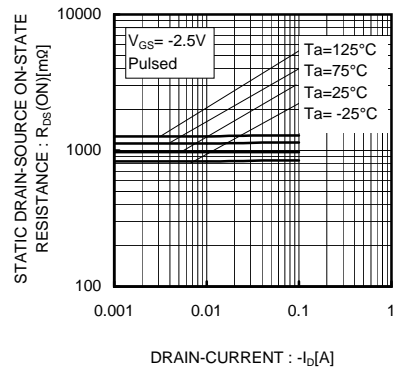
GATE-SOURCE VOLTAGE : -V<sub>GS</sub>[V]  
Fig.3 Typical Transfer Characteristics



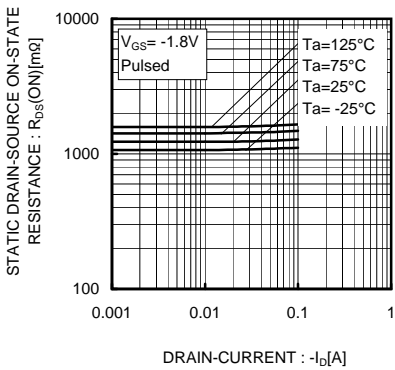
DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.4 Static Drain-Source On-State Resistance vs. Drain Current( I )



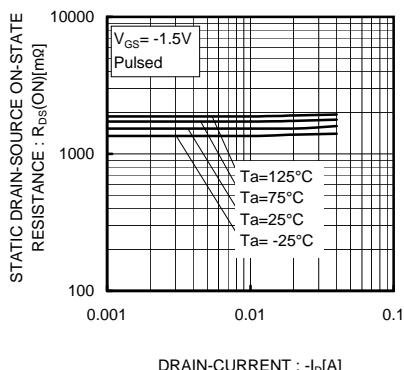
DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.5 Static Drain-Source On-State Resistance vs. Drain Current( II )



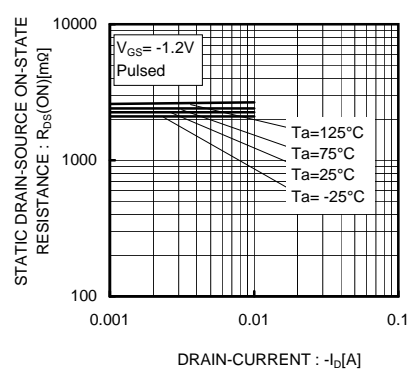
DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.6 Static Drain-Source On-State Resistance vs. Drain Current( III )



DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.7 Static Drain-Source On-State Resistance vs. Drain Current( IV )



DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.8 Static Drain-Source On-State Resistance vs. Drain Current( V )



DRAIN-CURRENT : -I<sub>D</sub>[A]  
Fig.9 Static Drain-Source On-State Resistance vs. Drain Current( VI )

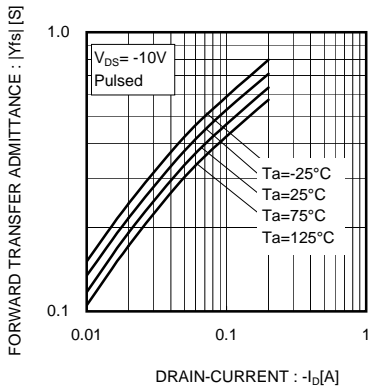


Fig.10 Forward Transfer Admittance vs. Drain Current

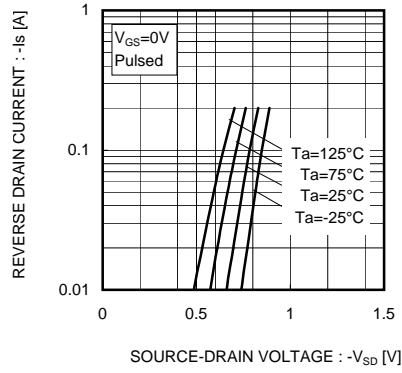


Fig.11 Reverse Drain Current vs. Source-Drain Voltage

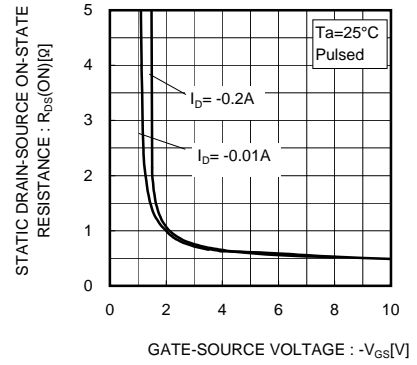


Fig.12 Static Drain-Source On-State Resistance vs. Gate Source Voltage

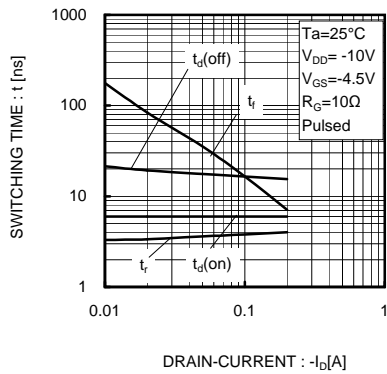


Fig.13 Switching Characteristics

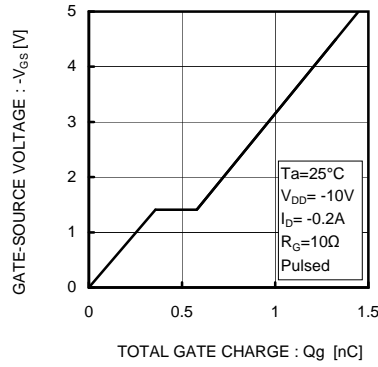


Fig.14 Dynamic Input Characteristics

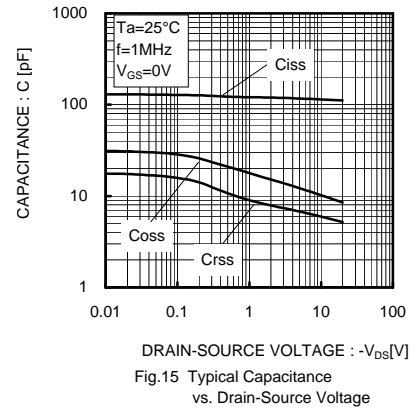


Fig.15 Typical Capacitance vs. Drain-Source Voltage

● Measurement circuits

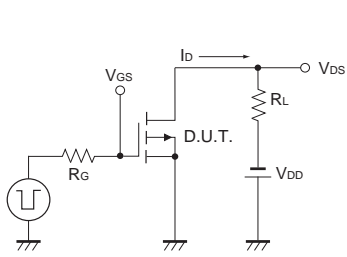


Fig.1-1 Switching Time Measurement Circuit

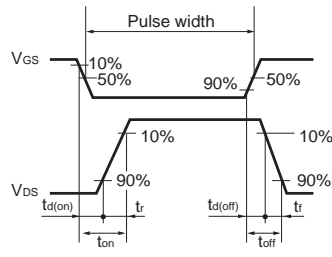


Fig.1-2 Switching Waveforms

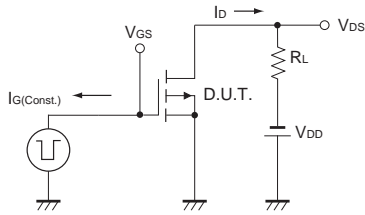


Fig.2-1 Gate Charge Measurement Circuit

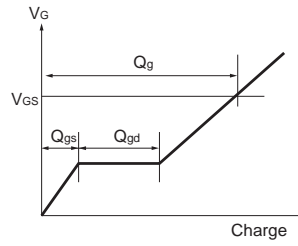


Fig.2-2 Gate Charge Waveform

● Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

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